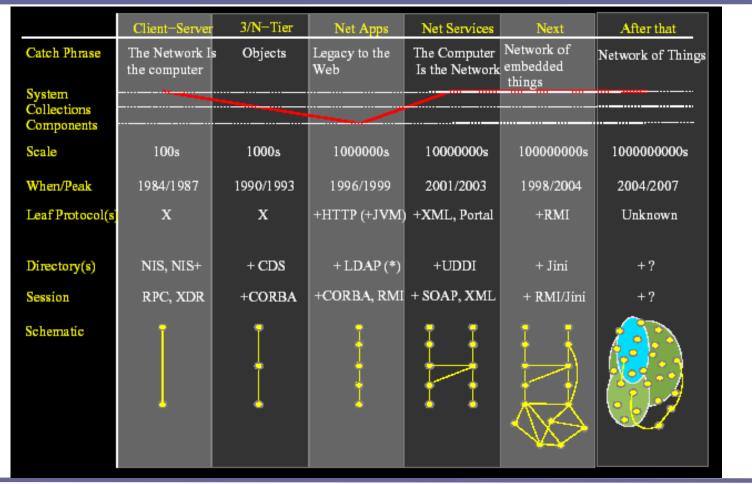
# **Reliability Through Telemetry**

Kenny Gross Oct 14, 2004 Sun Microsystems





# **Evolution Vision**



Sun Proprietary/Confidential Internal Use Only Sun Microsystems



# **Correlation and Causality**

- Correlation: Event A happens with Event B
  Association
- Causality: Event A causes Event B
  - Association
  - Temporal Precedence
  - Non-spurious association
  - Mechanism

# Key Enabler: Continuous System Telemetry

Sun Microsystems

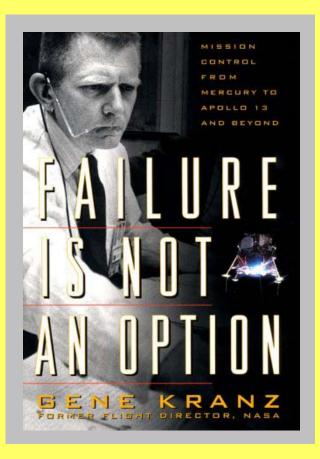


# Why is Availability Important?

#### To Customers

- -Downtime very costly
  - Measured by lost sales, reduced productivity, damaged business reputation, diminished customer loyalty
- To Sun Microsystems
  - -Means of differentiation
  - -Key corporate initiative
  - -Goal to provide continuous application access with predictable performance

# In today's eCommerce-based computing model ...



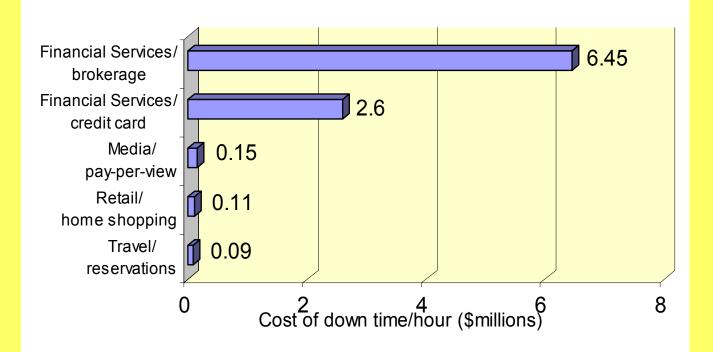
Mission director, Apollo 13



# Costs of downtime can be substantial

### Quantitative

- Lost business, lost productivity



Qualitative

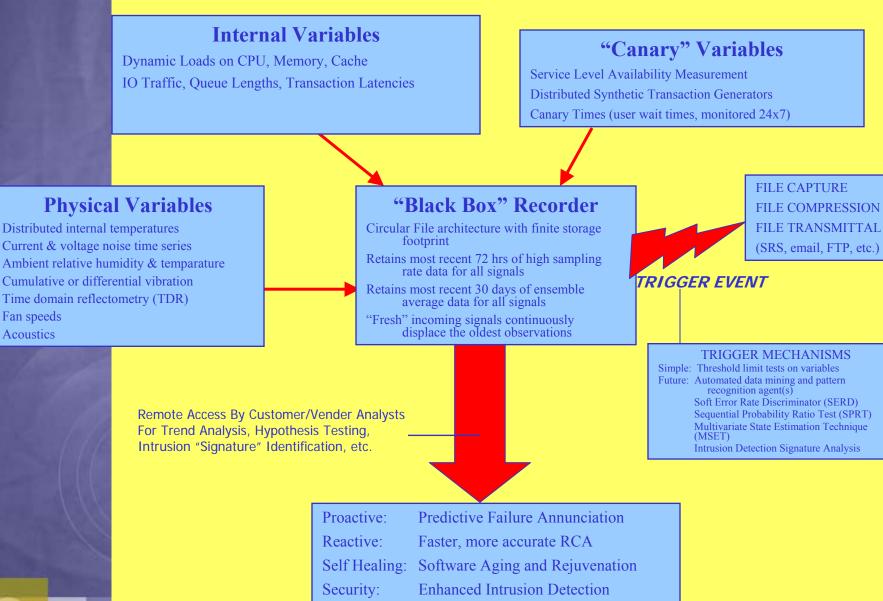
 Diminished reputation

Source: Hennessy and Patterson, Computer Architecture, Ch 1, Morgan & Kaufmann Publishers (2002).

Sun Proprietary/Confidential Internal Use Only GE and Sun Microsystems



#### Realtime Telemetry Harness for Enhanced Availability and Avoidance of "No-Trouble-Founds"

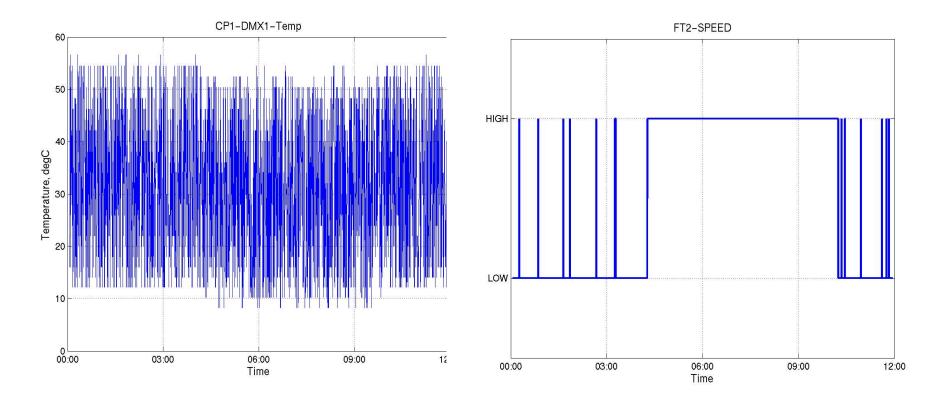


Sun Microsystems



### **Early Telemetry Harness Success on StarCat Platform**

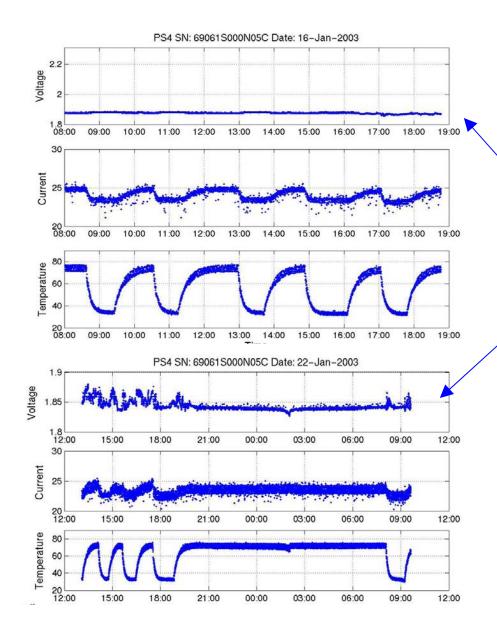
#### Starcat EMS bug identified during first week of telemetry testing of F15K.



StarCat SMS reporting processor temperature improperly. Note wild swings between 12-50 deg C.

Faulty temperature values cause fans to continuously cycle between low and high (1 of 8 fans shown).

Sun Proprietary/Confidential: Internal Use Only



#### **CSTH** for NTF Mitagation

Ongoing thermal cycling experiments with NTF power supplies from E10Ks

Upper plots show flat voltage during temperature cycling with undegraded power supply.

 Lower plots show voltage fluctuations from degrading power supply.

Voltage fluctuations from degrading power supplies are causing the system boards to throw out a number of failure messages, including:

•DTAG failures
•DTAG parity errors
•Ecache Failures
•Coherent processor errors
•UPA fatal error
•UPA parity error



## Advanced Pattern Recognition

#### **Motivation:**

Proactive fault monitoring (Detect incipient failures)
 System Availability
 Serviceability Costs
 Faster, more accurate Root Cause Analysis (RCA)...Each failure is used to build better future systems

#### Approach:

Adapt advanced statistical pattern recognition algorithm, MSET, that has been proven in a broad spectrum of safety-critical and mission-critical application domains.

#### **BENEFITS**:

- Enhanced end-to-end stack availability through predictive fault monitoring.
- Faster, more accurate RCA; Mitigation of No-Trouble-Founds (NTFs)
- Provides "Intelligent Agent" functionality when integrated with real time telemetry harness for monitored assets
- Improved stability analysis, dynamic resource provisioning for networks of interacting dynamic elements
- Closed-loop autonomic control for future servers and networks



#### New and Ongoing Proactive Fault Monitoring Projects:

- Continuous signal validation, sensor operability validation in servers
- "Inferential Sensing", allows analytical sensor replacement (i.e. temp sensor fails on StarCat system board, can swap in MSET estimate until the FRU needs to be replaced for other reasons).
- > Dynamic resource provisioning for Eagle and Post-Eagle platforms
- Software aging problems at customer sites (memory leaks, resource contention issues)
  - Successful pilot project applied MSET to complex S/W aging problem on SunPeak business critical E10Ks; Recent additional successes with SunRay servers
- Improved environmental-variable proactive fault detection
  - Detects flow perturbations & partial blockages, dirty air filters
  - Detects degraded/failed fans without RPM sensors
- Closed-loop autonomic control for improved (and less humanintensive) performance management of servers and networks
- Proactive fault monitoring and more accurate RCA for mitigating NTFs and ELFs
- Stability assurance for N1 networks of dynamically interacting systems.



### Advanced Pattern Recognition Tools for Ultrahigh-Reliability Surveillance

For Stationary Time Series

For Dynamic Time Series

#### Sequential Probability Ratio Test (SPRT)

- Advanced pattern recognition technique for high sensitivity, high reliability sensor and equipment operability surveillance.
- Developers proved in refereed journals that the SPRT provides the earliest mathematically possible annunciation of a subtle fault in noisy process variables.

#### Multivariate State Estimation Technique (MSET)

- Online model-based fault detection and identification.
- MSET predicts what each process should be on the basis of learned correlations among all process variables.
- MSET incorporates the SPRT to monitor the residuals between the actual observations and the estimates MSET predicts on the basis of the correlated variables.



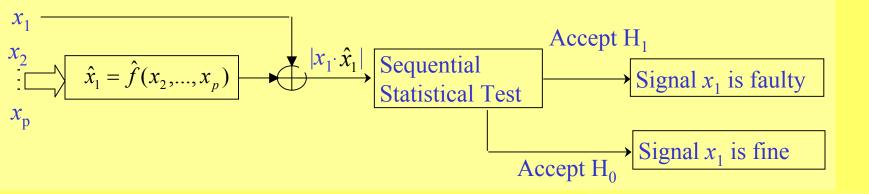
# Monitoring Practice Today: Thresholds not adequate

Users typically set alert thresholds and then use tools to correlate multiple alerts and trigger alarms, but:

- Thresholds are difficult to set accurately;
- Static thresholds are either too tight or too loose;
- Correlations are not obvious or intuitive
- Tradeoff between false alarms vs. sensitivity leads users to ignore indicators til it's too late

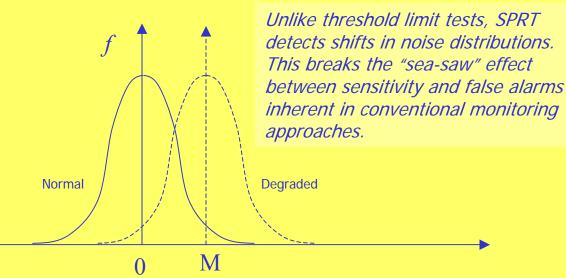
## Sequential Probability Ratio Test (SPRT)

High sensitivity for subtle anomaly detection, but without increasing false alarm probability.



Sequential test for residual signals is based upon two hypotheses:

 $H_0: \mu = \mu_0 = 0$   $H_1: \mu = \mu_1 = M$ where  $\mu$  is the mean of the distribution under test and M is a preset alarm threshold.



Sun Proprietary/Confidential Internal Use Only GE and Sun Microsystems



### MSET Multivariate State Estimation Technique

Argonne National Laboratory developed an advanced pattern recognition system, MSET, for 24X7 predictive fault monitoring in complex engineering systems for extremely sensitive identification of the onset of component degradation or process anomalies.

MSET possesses unique surveillance capabilities that surpass any conventional approaches, including neural networks, in sensitivity, reliability, and computational efficiency.

**MSET Provides:** 

- Continuous signal validation and sensor operability validation for safety-critical and mission-critical applications
- Incipient fault annunciation in all monitored components and process variables
- Extremely low probability of false alarms
- Improved dynamic feedback/control algorithms (MSET estimate can be used for control variable)

The MSET incipient fault surveillance system won a 1998 R&D-100 Award from R&D Journal for one of the top 100 technological breakthroughs for 1998.

In 2000, MSET won Control Engineering Magazine's "Editor's Choice Top 40 Awards."

In 2001, MSET won a Best of Sensors Expo new product "Gold Award". Sun Microsystems

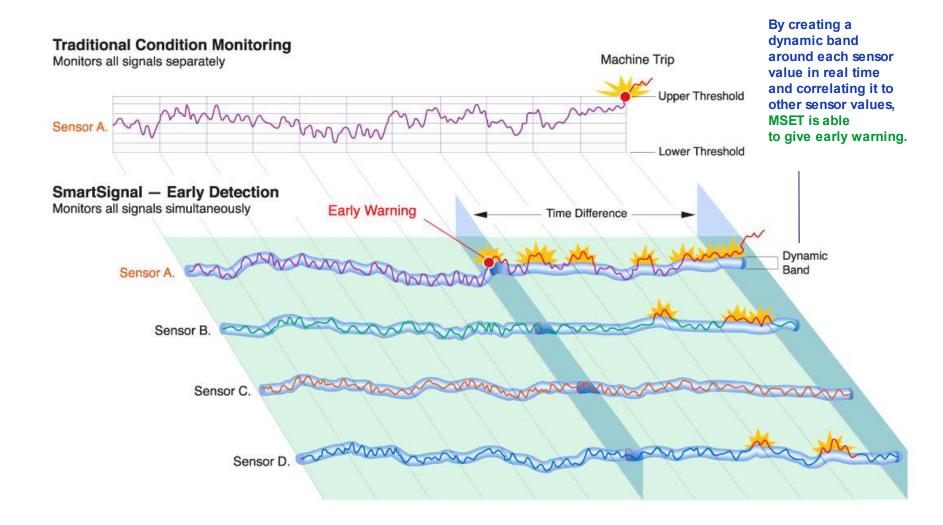
# Telemetry + pattern recognition allow early prediction of failures

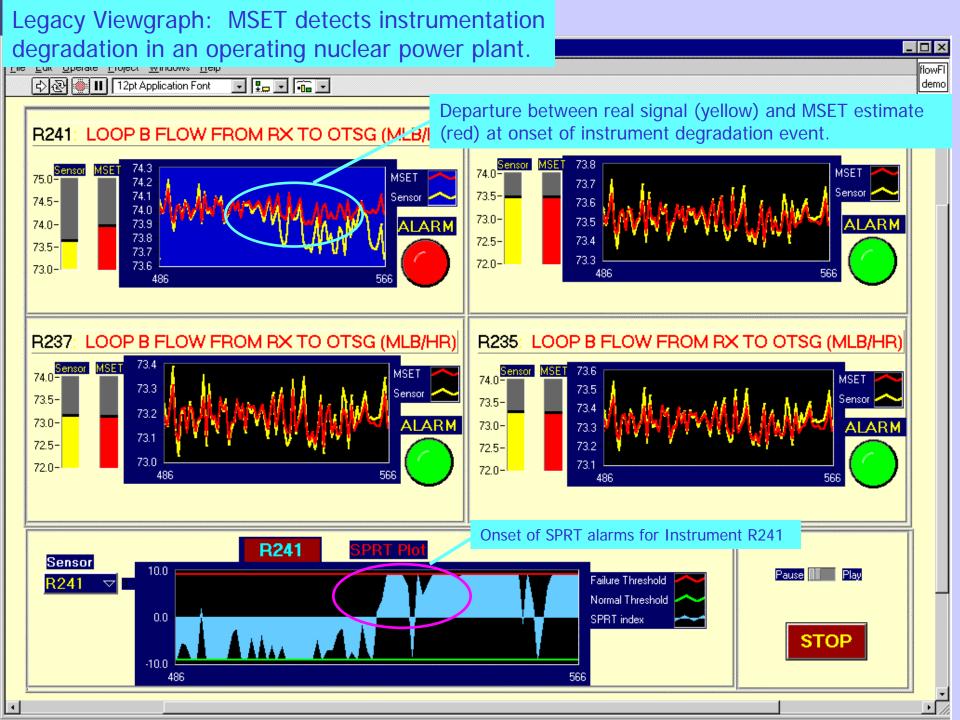
Traditional Monitoring: High/Low Thresholds

Traditional monitoring techniques are limited in their ability to identify failures proactively



# CSTH + MSET Pattern Recognition: Early Detection







# **Software Rejuvenation**

### Software Aging Problems:

Resource contention phenomenon that can cause servers to hang or crash. Mechanisms can include:

Memory leaks; Unreleased file locks; Accumulation of unterminated threads; Data corruption/round off accrual; File space fragmentation; Shared memory pool latching; Thread stack bloating and overruns

#### Software Rejuvenation:

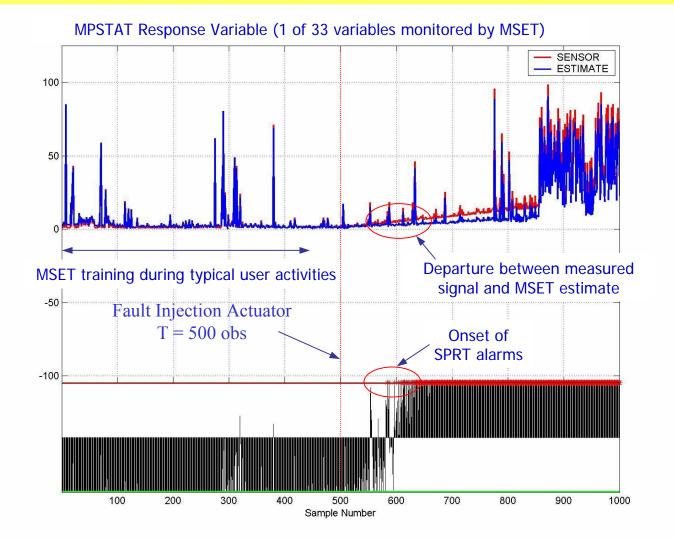
Proactive fault management technique to periodically "cleanse" the system internal state. Mechanisms can include:

Flushing stale locks; Reinitializing application components; Preemptive rollback; Memory defragmentation; Purging DB shared-pool latches; Node/application failover (cluster machines); Therapeutic reboots (primarily Wintel platforms)



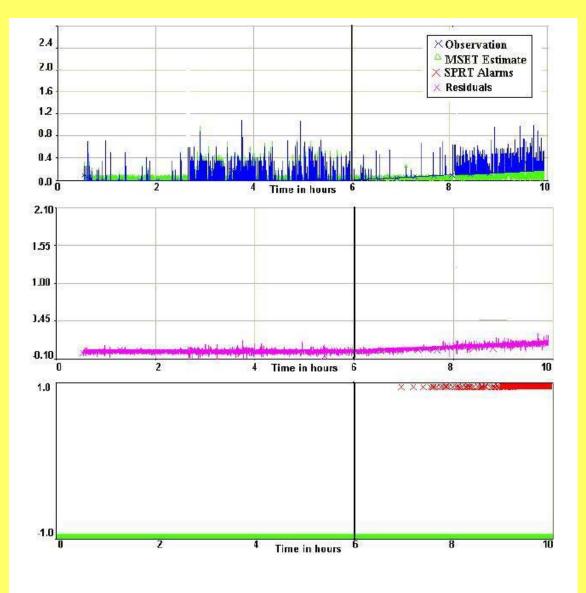
#### MSET Experiments with Software Aging and Rejuvenation

- •MSET trained on 33 performance variables sampled in realtime
- •Signals generated by standard Unix utilities (mpstat, iostat, cpustat)
- •Subtle, linearly degrading memory leaks simulated
- •MSET consistently demonstrated high alarm sensitivity with no false alarms





MSET Experiments with Controlled Parasitic Resource Consumption *Top :* Observation and MSET Estimate *Middle :* Residuals *Bottom :* SPRT Alarms



Sun Microsystems



### **Thermal Anomalies Cause Customer Outages**

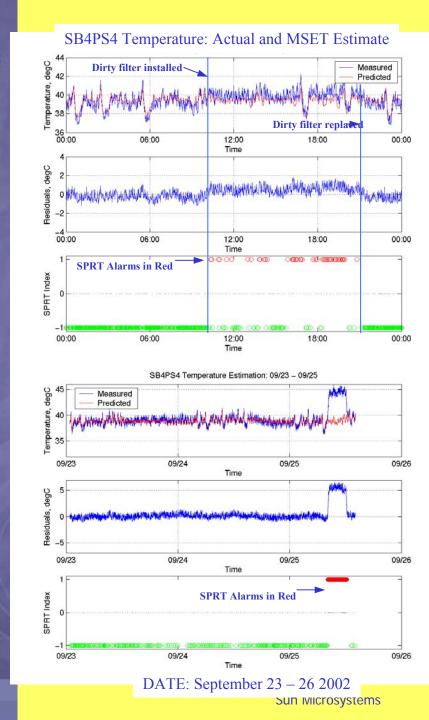
Sun servers have high-temperature protection thresholds, but the thresholds are quite high (85-110 deg C)

Many customer service calls originate from thermal problems that have much lower temperatures, but lead to long term reliability issues.

Examples:

- Failing to change air filters
- Running cables in raised-floor cool-air channel
- Scrap papers get sucked onto bottom air inlet grill
- Inadvertently configuring hot-air exhaust from one machine into cold-air inlet of another

MSET detects all types of thermal perturbations with a high sensitivity and minimal false alarm probability.

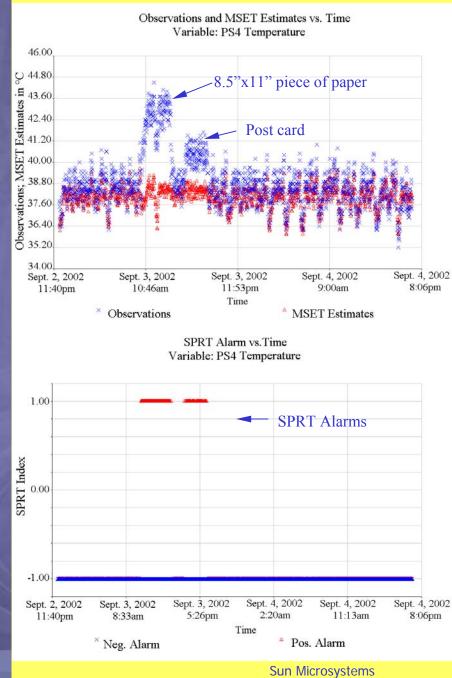


#### MSET Detects Fouled Air Filters in Enterprise Servers

#### MSET Detects Degraded/Failed Fans

(Eliminates Need for Hall-Effect RPM Sensors)





#### MSET Detects Coolant Air Flow Perturbations in Enterprise Servers

Occasional cause of service problems with high end servers: piece of paper falls from wall, notebook, etc. Works its way to bottom air inlet for server. Temps are not high enough to trip threshold; but over long term, can lead to accelerated reliability issues.

Experiments conducted with fully loaded E10K. MSET monitors dozens of performance variables. Piece of paper put on bottom air inlet.

Immediate SPRT alarms observed.

2<sup>nd</sup> experiment conducted with 3x5 post card.



# **Software Rejuvenation**

### Software Aging Problems:

Resource contention phenomenon that can cause servers to hang or crash. Mechanisms can include:

Memory leaks; Unreleased file locks; Accumulation of unterminated threads; Data corruption/round off accrual; File space fragmentation; Shared memory pool latching; Thread stack bloating and overruns

#### Software Rejuvenation:

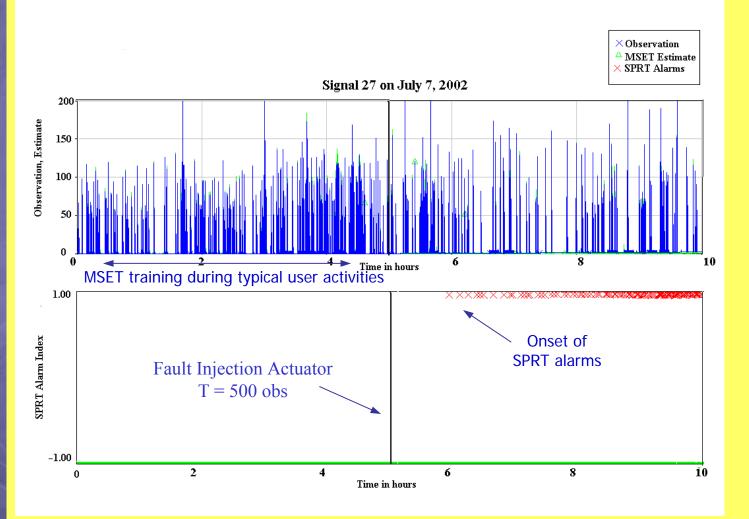
Proactive fault management technique to periodically "cleanse" the system internal state. Mechanisms can include:

Flushing stale locks; Reinitializing application components; Preemptive rollback; Memory defragmentation; Purging DB shared-pool latches; Node/application failover (cluster machines); Therapeutic reboots (primarily Wintel platforms)



SunRay Server Experiments with Controlled Parasitic Resource Consumption

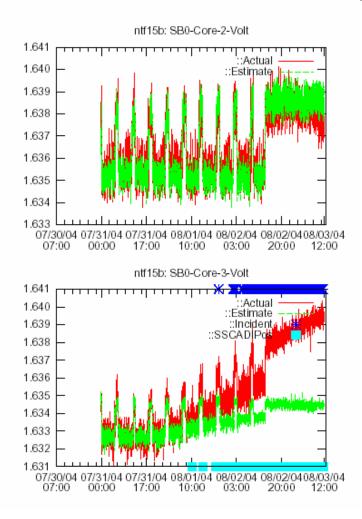
MSET Detection of Onset of Software Aging Mechanism in Signal 27 Parasitic Resource Consumption Rate = 1% per 24 Hrs



Sun Proprietary/Confidential Internal Use Only GE and Sun Microsystems

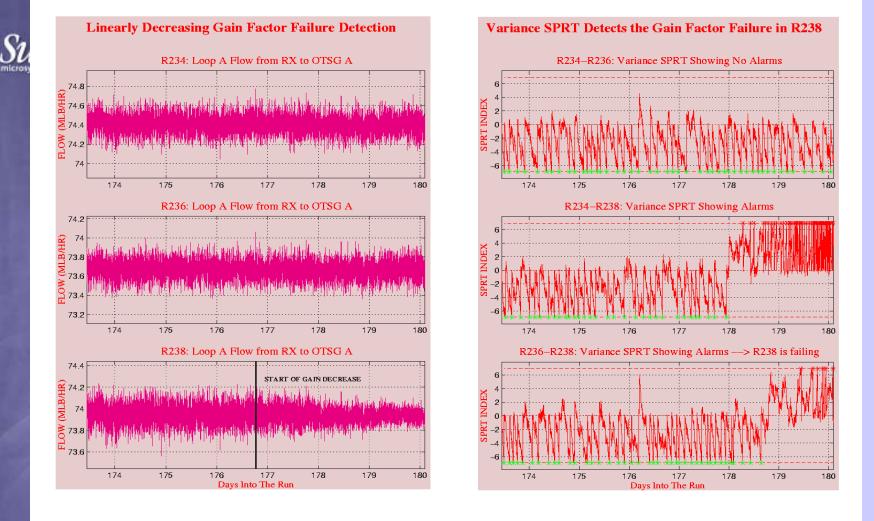


### New eCM MatLab Toolkit Detects Drifting Power Supply Voltages



Can detect anomalies in nominally stationary signals.

eCM automatically takes into account load effects by monitoring correlated signals.



#### Use of Pattern Recognition with Six Sigma:

Note that advanced pattern recognition is useful not only for detecting the onset of degradation. MSET can also detect and quantitatively characterize the onset of process improvements, including the reduction in processes variability.



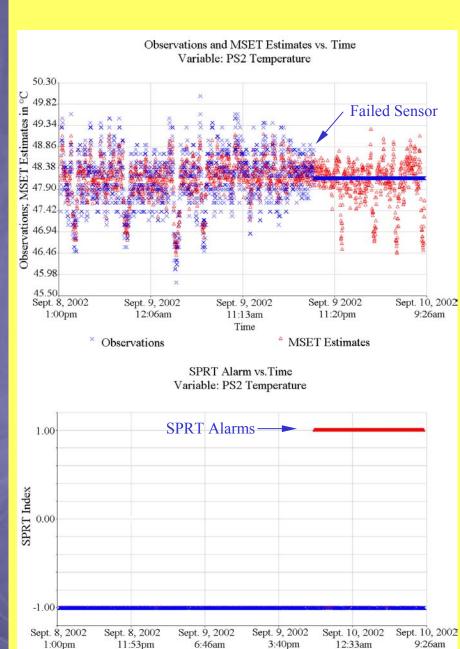
### **Inferential Sensing**

Sun's high-end servers contain hundreds of physical sensors (distributed board, module, and ASIC temperature sensors, voltages, and currents) that protect the system by detecting when a parameter is out of bounds, and then shutting down a component, system board, domain, or entire system.

When a sensor failure is detected, a pattern recognition module swaps out the degraded sensor signal, and swaps in an "analytical estimate" of the physical variable. The analytical estimate is supplied by the pattern recognition algorithm and is called an "inferential sensor". This analytical estimate can be used indefinitely, or until the Field Replaceable Unit (FRU) containing the failed sensor needs to be replaced for other reasons.

Example: If a temp sensor fails on a Starcat system board, the pattern recognition module can replace the failed sensor signal with an analytical estimate (the "inferential sensor") until the FRU is replaced. (With IBM systems it is necessary to replace the entire system board when a sensor fails, or to multiply complexity by deploying redundant sensors).





Time

Var Nom Alarm

Sun Microsystems

<sup>×</sup> Var Inv Alarm

#### Inferential Sensors via MSET

Physical sensors can fail. In many cases, the physical sensors have a shorter MTBF than the assets the sensors are supposed to protect.

With MSET, if a physical sensor fails or degrades in service, MSET can mask the sensor signal and swap in the MSET estimate (red variable in figure).

Immediate SPRT alarms observed.



### **Realtime Sensor Validation: Benefits**

All control actuator functions now use fully validated signals

For many (perhaps most) industrial systems, including Sun high-end servers, the sensors often have shorter MTBFs than the assets they are supposed to protect

MSET has a unique capability, called inferential sensing, to detect the onset of sensor degradation and swap in a highly accurate analytical estimate. Sensor replacement can be postponed until the next scheduled outage.

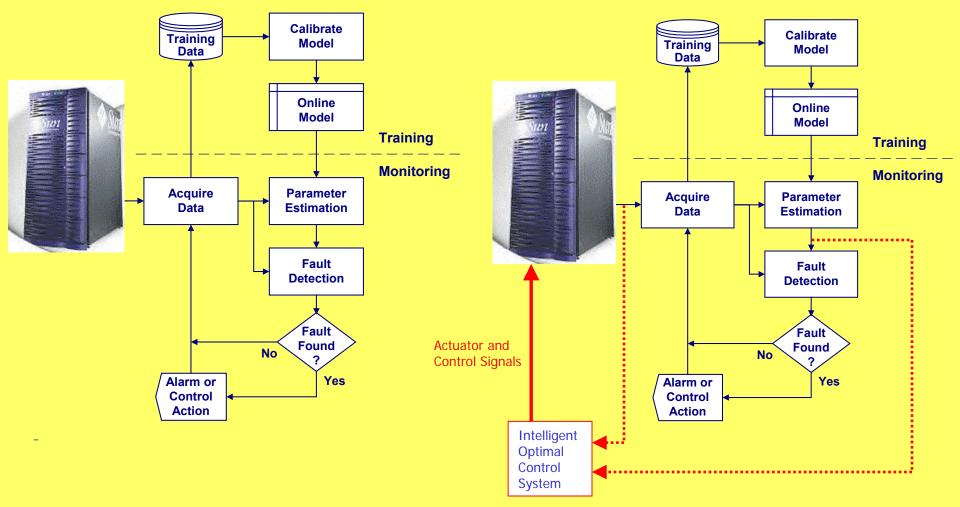
### Sun System Dynamics Characterization and Control

### MSET Now:

- Global System TelemetryProactive Fault Monitoring
- ➢Enhanced RCA
- ➤Mitigate NTFs

### MSET For the Future:

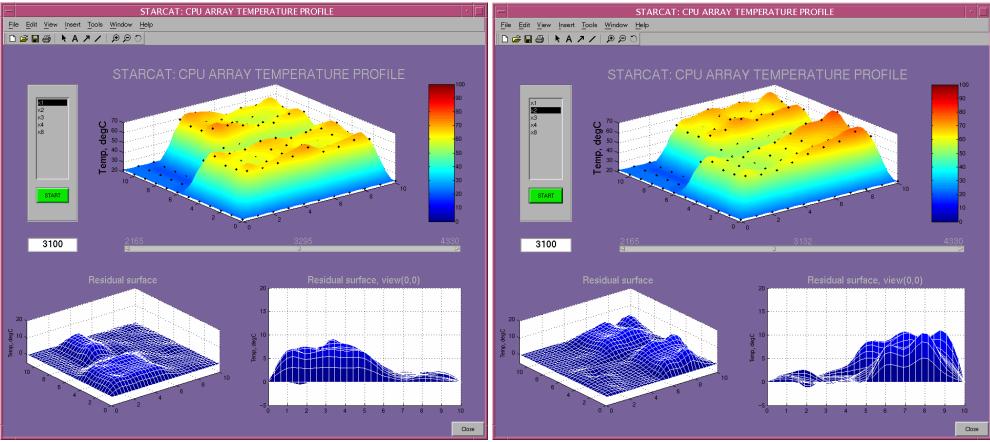
- ➢Realtime Stability Assurance (N1)
- >Dynamic Resource Provisioning
- Self Healing and Realtime Fault Avoidance
- Closed Loop Autonomic Control





# 3D Dynamic Viewing Tool

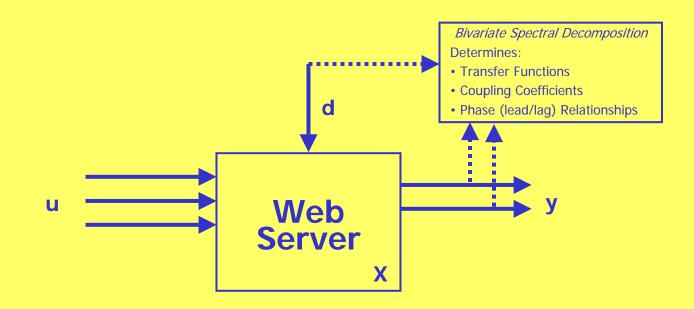
- Displays 3D temperature profiles at horizontal cross sections of the server
- Note that blue dots on the 3D surfaces below are actual StarCat temp sensors
- Capabilities are being extended to view voltage and current profiles during dynamic load-perturbation experiments



Sun Proprietary/ Confidential: Internal Use Only



### New Approach for Dynamical System Characterization of Enterprise Servers



- Inputs, u Typical user workload transactions
- Outputs, y
   Performance metrics (e.g. loads, throughput, queue lengths, transaction latencies, etc.)
- States, x Dynamical system states inferred via MSET
- Disturbances, d Small-amplitude, multifrequency sinusoidal load perturbations
- ✤ y = S[u,d] Bivariate spectral decomposition via the Normalized Cross Power Spectral Density (NCPSD) algorithm

Sun Proprietary/Confidential Internal Use Only GE and Sun Microsystems

#### CSTH Lab Console Displays For Coordination Of Dynamical System Characterization Experiments





# Summary

- System telemetry harness provides "Black Box Flight Recorder"
- Can "roll back" signals to identify signatures that lead to crashes
- Observability mitigates complexity!
- Use MSET-based pattern recognition technology to interpret monitoring data on line, in real time (or can postprocess archived telemetry data)
- Can enhance RAS and Quality of Service (QoS)
- Can mitigate No-Trouble-Founds (NTFs)
- Next generation system for N1 stability assurance, dynamic provisioning, & optimal control.

# **Bibliography**

#### Recent RASCAL Pubs on Telemetry + Adv. Pattern Recognition for Enhanced Dependability of

#### Complex Systems and Networks

"Frequency-Domain Pattern Recognition for Dynamic System Characterization of Enterprise Servers," K. Gross and K. Mishra, at the 2003 International Conference on Artificial Intelligence (IC-AI'03), Las Vegas, NV (June 23-26, 2003).

"Remote Analysis and Measurement of Software Systems," A. Porter, S. McMaster, A. Urmanov, L. Votta and K. Gross, 2003 Intn'l Conf. on Software Engineering (ICSE), Portland, OR (May 9, 2003)

"Spectral Decomposition of Performance Variables for Dynamic System Characterization of Web Servers," K. C. Gross, W. Lu, and K. Mishra, *Proc. 2002 SAS Users Group International (SUGI 28)*, Seattle, Wa. (Mar 30 - Apr 2, 2003).

"Proactive Detection of Software Aging Mechanisms in Performance-Critical Computers," K. C. Gross, V. Bhardwaj, R. L. Bickford, *Proc. 27<sup>th</sup> Annual IEEE/NASA Software Engineering Symp.*, Greenbelt, MD, (Dec 4-6, 2002.)

"Time-Series Investigation of Anomalous CRC Error Patterns in Fibre Channel Arbitrated Loops," K. C. Gross, W. Lu, and D. Huang, *Proc. 2002 IEEE Int'l Conf. on Machine Learning and Applications (ICMLA)*, Las Vegas, NV (June 2002).

"Early Detection of Signal and Process Anomalies in Enterprise Computing Systems," K. C. Gross and W. Lu, *Proc. 2002\_IEEE Int'l Conf. on Machine Learning and Applications (ICMLA)*, Las Vegas, NV (June 2002).

"Advanced Pattern Recognition for Detection of Complex Software Aging Phenomena in Online Transaction Processing Servers," Karen J. Cassidy, Kenny C. Gross, and Amir Malekpour, *Proc. Intnl. Performance and Dependability Symposium*, Washington, DC, (June 23<sup>rd</sup> - 26<sup>th</sup>, 2002).

"Software Reliability and System Availability at Sun," K. C. Gross, *Proc. IEEE 11<sup>th</sup> Intn'l Symp. On Software Reliability Eng.* (ISSRE02), San Jose, CA (Oct 2000).

"Uncertainty Analysis for Multivariate State Estimation in Mission-Critical and Safety-Critical Applications," N. Zavaljevski and K. C. Gross, *Proc. MARCON 2000,* "Maintenance and Reliability in the 21<sup>st</sup> Century", Knoxville, TN, (May 7-10, 2000).

"Support Vector Machines for Multivariate State Estimation," N. Zavaljevski and K. C. Gross, *Proc. ANS Intnl. Topical Mtg. On* "*Advances in Reactor Physics, Mathematics, and Computation into the Next Millennium,*" Pittsburgh, PA, (May 7-11, 2000).